L	Hits	Search Text	DB	Time stamp
Number				
1	1	tortuous adj gate	USPAT;	2003/09/30
			EPO; JPO;	14:42
			DERWENT	
2	0	20030080352.URPN.	USPAT	2003/09/30
1			1	14:42
3	30	MOSFET and asymmetric near3 (source near2	USPAT;	2003/09/30
		drain) with gate	EPO; JPO;	14:44
			DERWENT	